

<b>Notice of References Cited</b>	Application/Control No. 10/650,045	Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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	B	US-6,432,589	08-2002	Uchinokura et al.	430/18
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**NON-PATENT DOCUMENTS**

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